Search Notes

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Applicant(s)/Patent Under Reexamination FUKUCHI ET AL.

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Wai-Sing Louie

Art Unit

Examiner

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	SEARC	CHED	
Class	Subclass	Date	Examiner
257	211,503,508	5/28/09	WSL

SEARCH NOTES		
Search Notes	Date	Examiner
TFT, LCD, gate insulation, semiconductor active layer, source/ drain wiring, mobility, hydrogen content	1/13/09	WSL
followup search	5/28/09	WSL

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner
257	211,503,508	5/28/09	WSL

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